# IS43R16800A



PRELIMINARY INFORMATION JULY 2005

## 8Meg x 16 128-MBIT DDR SDRAM

## FEATURES

- Clock Frequency: 200, 125 MHz
- Power supply (VDD and VDDQ): 2.6V
- SSTL 2 interface
- Four internal banks to hide row Pre-charge and Active operations
- Commands and addresses register on positive clock edges (CLK)
- Bi-directional Data Strobe signal for data capture
- Differential clock inputs (CLK and CLK) for two data accesses per clock cycle
- Data Mask feature for Writes supported
- DLL aligns data I/O and Data Strobe transitions with clock inputs
- Half-strength and Matched drive strength options
- Programmable burst length for Read and Write operations
- Programmable CAS Latency (3 clocks)
- Programmable burst sequence: sequential or interleaved
- Burst concatenation and truncation supported for maximum data throughput
- Auto Pre-charge option for each Read or Write burst
- 4096 refresh cycles every 64ms
- Auto Refresh and Self Refresh Modes
- Pre-charge Power Down and Active Power Down Modes
- Industrial Temperature Availability
- Lead-free Availability

## **DEVICE OVERVIEW**

ISSI's 128-Mbit DDR SDRAM achieves high-speed data transfer using pipeline architecture and two data word accesses per clock cycle. The 134,217,728-bit memory array is internally organized as four banks of 32M-bit to allow concurrent operations. The pipeline allows Read and Write burst accesses to be virtually continuous, with the option to concatenate or truncate the bursts. The programmable features of burst length, burst sequence and CAS latency enable further advantages. The device is available in 16-bit data word size. Input data is registered on the I/O pins on both edges of Data Strobe signal(s), while output data is referenced to both edges of Data Strobe and both edges of CLK. Commands are registered on the positive edges of CLK. Auto Refresh, Active Power Down, and Pre-charge Power Down modes are enabled by using clock enable (CKE) and other inputs in an industry-standard sequence. All input and output voltage levels are compatible with SSTL 2.

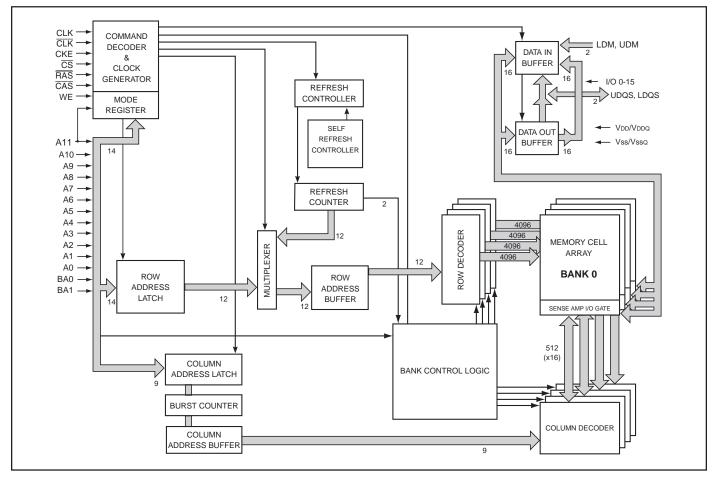
#### IS43R16800A

1M x16x8 Banks VDD: 2.6V VDDQ: 2.6V 66-pin TSOP-II

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FUNCTIONAL BLOCK DIAGRAM (x16)



## PIN CONFIGURATIONS 66 pin TSOP - Type II for x16

| VDD 🗌  |       | ☐ Vss  |
|--------|-------|--------|
| DQ0    | 2 65  | DQ15   |
| VDDQ   | 3 64  |        |
| DQ1    | 4 63  | DQ14   |
| DQ2    | 5 62  | 1 DQ13 |
| VssQ [ | 6 61  |        |
| DQ3    | 7 60  | DQ12   |
| DQ4    | 8 59  |        |
| VDDQ   | 9 58  |        |
| DQ5 [[ | 10 57 |        |
| DQ6    | 11 56 |        |
| VssQ [ | 12 55 |        |
| DQ7 [[ |       | DQ8    |
| NC [[  | 14 53 |        |
| VDDQ [ | 15 52 | 🔟 Vssq |
| LDQS [ | 16 51 |        |
| NC [   | 17 50 |        |
| VDD [[ | 18 49 |        |
| NC [[  | 19 48 | 🔟 vss  |
| LDM [[ |       |        |
| WE [   |       |        |
|        |       |        |
| RAS [  |       | 🔟 СКЕ  |
|        |       |        |
| NC [   |       |        |
| BA0 🔲  |       | 1 A11  |
| BA1 [  |       | ☐ A9   |
| A10 [[ | 28 39 | ☐ A8   |
| A0 [[  |       | A7     |
| A1 [[  |       | 1 A6   |
| A2 [[  |       | 1 A5   |
| A3 [[  |       | 1 A4   |
| VDD [[ | 33 34 |        |
|        |       | 1      |

## **PIN DESCRIPTIONS**

| A0-A11      | Row Address Input             |
|-------------|-------------------------------|
| A0-A8       | Column Address Input          |
| BA0, BA1    | Bank Select Address           |
| DQ0 to DQ15 | Data I/O                      |
| CLK         | System Clock Input            |
| CKE         | Clock Enable                  |
| CS          | Chip Select                   |
| RAS         | Row Address Strobe Command    |
| CAS         | Column Address Strobe Command |

| WE         | Write Enable             |
|------------|--------------------------|
| LDM, UDM   | x16 Input/Output Mask    |
| LDQS, UDQS | Data Strobe              |
| VDD        | Power                    |
| Vss        | Ground                   |
| VDDQ       | Power Supply for I/O Pin |
| Vssq       | Ground for I/O Pin       |
| NC         | NoConnection             |
|            |                          |



## **PIN FUNCTIONS**

| Symbol          | Туре             | Function (In Detail)  |  |  |
|-----------------|------------------|---|--|--|
| A0-A11          | Input Pin        | Address inputs are sampled during several commands. During an Active command, A0-A11 select a row to open. During a Read or Write command, A0-A8 select a starting column for a burst. During a Pre-charge command, A10 determines whether all banks are to be pre-charged, or a single bank. During a Load Mode Register command, the address inputs select an operating mode.   |  |  |
| BA0, BA1        | Input Pin        | Bank Address inputs are used to select a bank during Active, Pre-charge,<br>Read, or Write commands. During a Load Mode Register command, BA0<br>and BA1 are used to select between the Base or Extended Mode Register  |  |  |
| CAS             | Input Pin        | $\overline{CAS}$ is Column Access Strobe, which is an input to the device command along with $\overline{RAS}$ and $\overline{WE}$ . See "Command Truth Table" for details.  |  |  |
| CKE             | Input Pin        | Clock Enable: CKE High activates and CKE Low de-activates internal clock signals and input/output buffers. When CKE goes Low, it can allow Self Refresh, Pre-charge Power Down, and Active Power Down. CKE must be High during entire Read and Write accesses. Input buffers except CLK, <b>CLK</b> , and CKE are disabled during Power Down. CKE uses an SSTL 2 input, but will detect a LVCMOS Low level after VDD is applied.  |  |  |
| CLK, <b>CLK</b> | Input Pin        | All address and command inputs are sampled on the rising edge of the clock input CLK and the falling edge of the differential clock input $\overline{\text{CLK}}$ . Output data is referenced from the crossings of CLK and $\overline{\text{CLK}}$ .   |  |  |
| CS              | Input Pin        | The Chip Select input enables the Command Decoding block of the device. When $\overline{CS}$ is disabled, a NOP occurs. See "Command Truth Table" for details. Multiple DDR SDRAM devices can be managed with $\overline{CS}$ .   |  |  |
| LDM, UDM        | Input Pin        | These are the Data Mask inputs. During a Write operation, the Data Mask input allows masking of the data bus. DM is sampled on each edge of DQS. There are two Data Mask input pins for the x16 DDR SDRAM. Each input applies to DQ0-DQ7, or DQ8-DQ15.  |  |  |
| LDQS, UDQS      | Input/Output Pin | These are the Data Strobe inputs. The Data Strobe is used for data capture.<br>During a Read operation, the DQS output signal from the device is edge-<br>aligned with valid data on the data bus. During a Write operation, the DQS<br>input should be issued to the DDR SDRAM device when the input values on<br>DQ inputs are stable. There are two Data Strobe pins for the x16 DDR<br>SDRAM. Each of the two Data Strobe pins applies to DQ0-DQ7, or DQ8-<br>DQ15. |  |  |
| DQ0-DQ15        | Input/Output Pin | The pins DQ0 to DQ15 represent the data bus. For Write operations, the data bus is sampled on Data Strobe. For Read operations, the data bus is sampled on the crossings of CK and $\overline{CK}$ .  |  |  |
| NC              | —                | No Connect: This pin should be left floating. These pins could be used for 256Mbit or higher density DDR SDRAM.   |  |  |
| RAS             | Input Pin        | <b>RAS</b> is Row Access Strobe, which is an input to the device command along with $\overline{CAS}$ and $\overline{WE}$ . See "Command Truth Table" for details.   |  |  |
| WE              | Input Pin        | $\overline{\text{WE}}$ is Write Enable, which is an input to the device command along with $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ . See "Command Truth Table" for details.   |  |  |
| VDDQ            | Power Supply Pin | VDDQ is the output buffer power supply.   |  |  |
| VDD             | Power Supply Pin | VDD is the device power supply.   |  |  |
| VREF            | Power Supply Pin | VREF is the reference voltage for SSTL 2.   |  |  |
| VSSQ            | Power Supply Pin | VSSQ is the output buffer ground.   |  |  |
| VSS             | Power Supply Pin | VSS is the device ground.   |  |  |

#### **ABSOLUTE MAXIMUM RATINGS(1)**

| Symbol    | Parameters                               | Rating       | Unit |  |
|-----------|--|--------------|------|--|
| VDD MAX   | Maximum Supply Voltage                   | -1.0 to +3.6 | V    |  |
| VDDQMAX   | Maximum Supply Voltage for Output Buffer | -1.0 to +3.6 | V    |  |
| Vin, Vref | Input Voltage, Reference Voltage         | -1.0 to +3.6 | V    |  |
| PD MAX    | Allowable Power Dissipation              | 1            | W    |  |
| lcs       | Output Shorted Current                   | 50           | mA   |  |
| Topr      | Operating Temperature Com.               | 0 to +70     | C°   |  |
| Tstg      | StorageTemperature                       | -55 to +125  | C°   |  |

Notes:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. All voltages are referenced to Vss.

#### RECOMMENDED DC OPERATING CONDITIONS (SSTL\_2 Input/Output, TA = 0°C to +70°C)

| Symbol                 | Parameter  | Test Condition  | Min              | Тур.       | Max              | Unit |
|------------------------|--|---|------------------|------------|------------------|------|
| Vdd                    | Supply Voltage                                   |   | 2.5              | 2.6        | 2.7              | V    |
| Vddq^(1)               | I/O Supply Voltage                               |   | 2.5              | 2.6        | 2.7              | V    |
| Vtt                    | I/O Termination Voltage                          |   | Vref - 0.04      | Vref       | Vref + 0.04      | V    |
| VIH <sup>(2)</sup>     | Input High Voltage                               |   | Vref + 0.15      | _          | VDDQ + 0.3       | V    |
| VIL <sup>(3)</sup>     | Input Low Voltage                                |   | Vssq - 0.3       | _          | Vddq - 0.15      | V    |
| Vref                   | I/O Reference Voltage                            |   | 0.49 x Vddq      | 0.5 x Vddq | 0.51 x Vddq      | V    |
| VIN(DC) <sup>(4)</sup> | Input Voltage Level for CLK and CLK              |   | -0.3             | —          | VDDQ + 0.3       | V    |
| Vix(DC)                | Crossing Point Voltage<br>Level for CLK and CLK  |   | 0.5 x Vddq - 0.2 | 0.5 x Vddq | 0.5 x VDDQ + 0.2 | V    |
| $Vid(DC)^{(5,6)}$      | Input Differential Voltage Level for CLK and CLK |   | 0.36             | —          | VDDQ + 0.6       | V    |
| l∟                     | Input Leakage Current                            | $0 \le V_{IN} \le V_{DD}$ , with all inputs at Vss, except tested input | -2               | —          | 2                | μA   |
| lol                    | Output Leakage Current                           | Output disabled;<br>0V ≤ Vout ≤ Vpdq                                    | -5               | _          | 5                | μA   |
| Vон                    | Output High Voltage<br>Level                     | lон = -15.2mA   | V⊤ + 0.76        | _          | _                | V    |
| Vol                    | Output Low Voltage<br>Level                      | IoL = +15.2mA   | _                |            | Vref - 0.76      | V    |

Note:

1. VDDQ must always be less than or equal to VDD.

2. VIH is allowed to exceed VDD up to 3.6V for the period shorter than or equal to 5ns.

3. VIL is allowed to drop to -1.0V for the period shorter than or equal to 5ns.

4. VIN(DC) specifies the allowable DC execution of each differential input.

5. VID(DC) specifies the input differential voltage required for switching.

6. VIH for CLK or CLK > VREF + 0.18V; VIL for CLK or CLK < VREF - 0.18V.

| Symbol | Parameter  | Min. | Max. | Unit |
|--------|--|------|------|------|
| CIN1   | Input Capacitance: CLK and CLK                   | 2    | 3    | рF   |
| CIN2   | Input Capacitance: All other input pins          | 2    | 3    | pF   |
| CIN3   | Data Mask Input/Output Capacitance: LDM/UDM      | 6    | 8    | pF   |
| Солт   | Data Input/Output Capacitance: DQs and LDQS/UDQS | 6    | 8    | pF   |

#### CAPACITANCE CHARACTERISTICS (At TA = 0 to +25°C, VDD = VDDQ = 2.6V, f = 100 MHz)

#### DC ELECTRICAL CHARACTERISTICS (1,2,3,4,5) (VDD = 2.6V +/- 0.1V, TA = 0°C to +70°C)

| SymbolParameter |                        | Test Condition   |     | Unit |
|-----------------|------------------------|--|-----|------|
| DD0             | Operating Current      | One bank operation; Active-Precharge; DQ, DM and DQS                         |     |      |
|                 |                        | inputs change once per clock cycle; Address and Control                      |     |      |
|                 |                        | inputs change once per two clock cycles; tRC = tRC (min)                     | 110 | mΑ   |
| DD1             | Operating Current      | One bank operation; Active-Read-Precharge; BL = 4; CL = 4;                   |     |      |
|                 |                        | Address and Control inputs change once per clock cycle;                      |     |      |
|                 |                        | tRCDRD = 4 x tCK; tRC = tRC (min); IOUT = 0mA;                               | 140 | mΑ   |
| DD2F            | Precharge Power-Down   | All banks Idle; tCK = tCK (min); CKE = Low                                   | 3   | mΑ   |
|                 | Standby Current        |  |     |      |
| DD2Q            | Idle Standby Current   | e Standby Current All banks idle; Address and control inputs change once per |     |      |
|                 |                        | clock cycle; CKE = High;   |     |      |
|                 |                        | for DQ, DQS, and DM; tCK = tCK (min)   | 30  | mΑ   |
| DD3P            | Active Power-Down      | One bank Active; CKE = Low; tCK = tCK (min)                                  |     | mΑ   |
|                 | Standby Current        |  |     |      |
| DD3N            | Active Standby Current | One bank Active; CS = High; CKE = High; Address and                          |     |      |
|                 |                        | Control inputs change once per clock cycle; DQ, DQS, and                     |     |      |
|                 |                        | DM change twice per clock cycle; tRC = tRC (max);                            | 55  | mΑ   |
| DD4R            | Operating Current      | One bank Active; BL = 2; Address and Control inputs                          |     |      |
|                 | Burst Read             | change once per clock cycle; tCK = tCK (min); IOUT = 0mA                     | 205 | mΑ   |
| DD4W            | Operating Current      | One bank Active; BL = 2; Address and Control inputs change                   |     |      |
|                 | Burst Write            | once per clock cycle; DQ, DQS, DM change twice per clock                     |     |      |
|                 |                        | cycle; CKE ≥ V⊮  | 205 | mΑ   |
| DD5             | Auto Refresh Current   | $tRC = tRFC (min); Input \le VIL or \ge VIH$                                 | 200 | mΑ   |
| DD6             | Self Refresh Current   | Input $\geq$ VDD-0.2V; Input $\leq$ 0.2V                                     | 3   | mΑ   |
| DD7             | Operating Current      | Four bank interleaved Reads with Auto Precharge; BL = 4;                     |     |      |
|                 |                        | Address and Controls inputs change per Read, Write, or                       |     |      |
|                 |                        | Active command; one bank with tRC = tRC (min)                                | 350 | mΑ   |

Notes:

1. Operating outside the "Absolute Maximum Ratings" may lead to temporary or permanent device failure.

2. Power up sequence describe in "Initialization" section.

3. All voltages are referenced to Vss.

4. IDD tested without DQ pins connected.

5. IDD values tested with  $tc\kappa = tc\kappa$  (min).

## AC ELECTRICAL CHARACTERISTICS (V<sub>DD</sub> = 2.6V + - 0.1V, T<sub>A</sub> = $0^{\circ}C$ to $+70^{\circ}C$ )

| -5(3-4-4)      |  |                |                   |      |      |
|----------------|--|----------------|-------------------|------|------|
| Symbol         | Parameter                              | Test Condition | Min.              | Max. | Unit |
| tск            | Clock Cycle Time                       | CL = 3         | 5                 | 10   | ns   |
| tсн            | Clock High Level Width                 |                | 0.45              | 0.55 | tск  |
| tc∟            | Clock Low Level Width                  |                | 0.45              | 0.55 | tск  |
| thp            | Clock Half Period                      |                | tcн or tc∟        |      | ns   |
| tac            | Output Access Time from CLK, CLK       |                | -0.7              | 0.7  | ns   |
| <b>t</b> DQSCK | DQS-Out Access Time from CLK, CLK      |                | -0.55             | 0.55 | ns   |
| tDQSQ          | DQS-DQ Skew                            |                | _                 | 0.4  | ns   |
| tqн            | Output DQS Valid Window                |                | thp - tqhs        |      | ns   |
| tqнs           | Data Hold Skew factor                  |                | _                 | 0.5  | ns   |
| tнz            | Data Out High Impedance time from CI   | _K, <u>CLK</u> |                   | 0.7  | ns   |
| t∟z            | Data Out Low Impedance time from CL    | К, <b>СLК</b>  | -0.7              | 0.7  | ns   |
| <b>t</b> RPRE  | Read Preamble                          |                | 0.9               | 1.1  | tск  |
| <b>t</b> RPST  | Read Postamble                         |                | 0.4               | 0.6  | tск  |
| tDQSS          | CLK to Valid DQS-In                    |                | 0.72              | 1.28 | tск  |
| toss           | DQS falling edge to CK setup time      |                | 0.2               |      | tск  |
| tdsн           | DQS falling edge hold time from CLK    |                | 0.2               |      | tск  |
| twpres         | Write Preamble Setup Time              |                | 0                 | _    | ns   |
| twpre          | Write Preamble                         |                | 0.25              |      | ns   |
| twpst          | Write Postamble                        |                | 0.4               | 0.6  | tск  |
| <b>t</b> DQSH  | DQS-In High Level Pulse Width          |                | 0.35              | _    | tск  |
| tdqsl          | DQS-In Low Level Pulse Width           |                | 0.35              |      | tск  |
| tis            | Address and Control Input Setup Time   |                | 0.6               |      | ns   |
| tıн            | Address and Control Input Hold Time    |                | 0.6               |      | ns   |
| tipw           | Address and Control Input Pulse Width  |                | 2.2               |      | ns   |
| tos            | DQ and DM Setup Time to DQS            |                | 0.4               |      | ns   |
| tDH            | DQ and DM Hold Time to DQS             |                | 0.4               |      | ns   |
| <b>t</b> RC    | Active to Active/ Auto Refresh Comma   | nd Period      | 60                | _    | ns   |
| <b>t</b> RFC   | Auto Refresh to Active/ Auto Refresh C | ommand Period  | 70                | _    | ns   |
| <b>t</b> RAS   | Active to Precharge Command Period     |                | 40                | 120K | ns   |
| <b>t</b> RCDRD | RAS to CAS Delay in Read               |                | 18                | _    | ns   |
| <b>t</b> RCDWR | RAS to CAS Delay in Write              |                | 18                | _    | ns   |
| <b>t</b> RP    | Row Pre-charge Time                    |                | 18                |      | ns   |
| <b>t</b> RAP   | Active to Auto Precharge delay         |                | trcomin.          |      | ns   |
| trrd           | Row Active to Row Active Delay         |                | 10                |      | ns   |
| twr            | Write Recovery Time                    |                | 15                |      | ns   |
| <b>t</b> MRD   | Mode Register Load Delay               |                | 2                 |      | tск  |
| <b>t</b> DAL   | Auto Pre-charge Write Recovery + Pre-  | charge         | twr/tck + trp/tck |      | tск  |
| <b>t</b> REF   | Refresh Interval Time                  |                | _                 | 15.6 | μs   |

Notes:

Operating outside the "Absolute Maximum Ratings" may lead to temporary or permanent device failure.
Power up sequence describe in "Initialization" section.
All voltages are referenced to Vss.

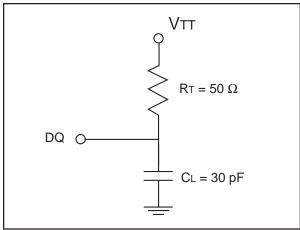


#### Notes:

- 1. All AC parameters measuremed with the following test conditions.
- 2. This parameter defines the signal transition delay from the crossing point of CK and CK. The signal transition is defined to occur when the signal level crosses VTT.
- 3. The timing reference level is VTT.
- 4. Output valid window is defined to be the period between two successive transition of data out or DQS (read) signals. The signal transition is defined to occur when the signal level crosses VTT.
- 5. tHz is defined as the data output transition delay from Low-Z to High-Z at the end of a read burst operation. The timing reference is the crossing point of CK and CK. This parameter is not referred to a specific voltage level, but when the device output stops driving.
- 6. tLz is defined as the data output transition delay from High-Z to Low-Z at the beginning of read operation. This parameter is referring to a specific voltage level, but when the device output begins driving.
- 7. Input valid windows is defined to be the period between two successive transition of data input or DQS (write) signals. The signal transition is defined to occur when the signal level crosses VREF.
- 8. The timing reference level is VREF.
- 9. The transition from Low-Z to High-Z is defined to occur when the device output stops driving. There is no specific reference voltage to judge this transition.
- 10. tck (max.) is determined by the locking range of the DLL. Beyond this lock range, the DLL operation is assured.
- 11. tck = tck (min) when these parameters are measured. Otherwise, absolute minimum values of these values are 10% of tck.
- 12. VDD is assumed to be 2.6V ± 0.1V. VDD power supply variation per cycle expected to be less than 0.4V per 400 cycles.
- 13. tDAL = (twR/tCK)+(tRP/tCK). For each of the add-ins, if not an integer already, round up to the nearest integer.

## AC TEST CONDITIONS

## **Output Load**



## AC TEST CONDITIONS

| Parameter   | Symbol   | Value              | Unit |  |
|---|----------|--------------------|------|--|
| Input High Voltage  | Viн (AC) | Vref + 0.31        | V    |  |
| Input Low Voltage   | Vı∟ (AC) | Vref <b>-</b> 0.31 | V    |  |
| Input Signal Slew Rate  | SLEW     | 1                  | V/ns |  |
| Input Timing Reference Level                                  | Vref     | VDDQ/2             | V    |  |
| Termination Voltage   | Vtt      | Vref               | V    |  |
| Input Differential Voltage (CLK and $\overline{\text{CLK}}$ ) | Vid (AC) | 0.62               | V    |  |
| Input Differential Crossing Voltage                           | Vix (AC) | Vref               | V    |  |

## **OPERATING FREQUENCY / LATENCY RELATIONSHIPS**

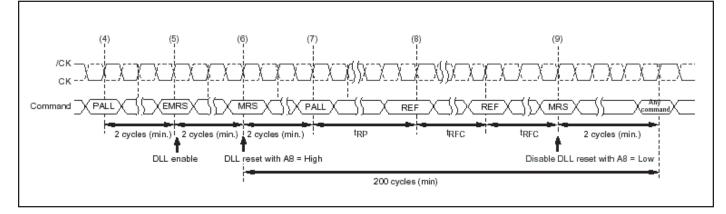
| SYMBOL        | PARAMETER  |          | UNITS |
|---------------|--|----------|-------|
| twpd          | Write to Pre-charge command delay (same bank)            | 4 + BL/2 | Cycle |
| <b>t</b> RPD  | Read to Pre-charge command delay (same bank)             | BL/2     | Cycle |
| twrd          | Write to Read command delay (to input all data)          | 2 + BL/2 | Cycle |
| <b>t</b> BSTW | Burst Stop command to Write command delay                | 3        | Cycle |
| <b>t</b> BSTZ | Burst Stop command to DQ High-Z                          | 3        | Cycle |
| trwd          | Read command to Write command delay (to output all data) | 3 + BL/2 | Cycle |
| <b>t</b> HZP  | Pre-charge command to High-Z                             | 3        | Cycle |
| twcD          | Write command to data in latency                         | 1        | Cycle |
| twr           | Write Recovery   | 3        | Cycle |
| <b>t</b> DMD  | DM to Data-In latency                                    | 0        | Cycle |
| <b>t</b> MRD  | Mode Register Set command cycle time                     | 2        | Cycle |
| tsnr          | Self Refresh Exit to non-read command                    | 15       | Cycle |
| tsrd          | Self Refresh Exit to Read command                        | 200      | Cycle |
| <b>t</b> PDEN | Power Down Entry   | 1        | Cycle |
| <b>t</b> PDEX | Power Down Exit to command input                         | 1        | Cycle |

## FUNCTIONAL DESCRIPTION

The 128Mbit DDR SDRAM is a high-speed CMOS device with four banks that operate at 2.6V. Each 32Mbit bank is organized as 4,096 rows of 512 columns for the x16 option. Pre-fetch architecture allows Read and Write accesses to be double-data rate and burst oriented. Accesses start at a selected column location and continue every half-clock cycle for a programmed number of times. The Read or Write operation begins with an Active command to transmit the selected bank and row (A0-A11 bits are sampled). This is followed by a Read or Write command to sample the address bits again to determine the first column to access. When access to the memory is not necessary, the device can be put into a Power Down mode in which current consumption is minimized. Prior to normal operation, the device must be initialized in a defined procedure to function properly. The following sections describe the steps of initialization, the mode register definitions, command descriptions, and device operation.

## **INITIALIZATION**

The DDR SDRAM must be powered-on and initialized in a series of defined steps for proper operation. First, power is applied to VDD, and then to VDDQ. After these have reached stable values, VREF and VTT are ramped up. If this sequence is not followed, latch-up could occur and cause damage to the device. The input CKE must be asserted and held to a LVCMOS Low level during this time to prevent unwanted commands from being executed. The outputs I/O and DQS remain in high impedance until driven during a normal operation. Once VDD, VDDQ, VTT, VREF, and CKE are stable values, the clock inputs can begin to be applied. For a time period of at least 200µs, valid CLK and CLK cycles must be applied prior to any command being issued to the device. CKE needs to then be raised to SSTL 2 logic High and issue a NOP or Deselect command to initialize the internal logic of the DRAM. Next, a Pre-charge All command is given to the device, followed by a NOP/Deselect command on each clock cycle for at least tRP. The Load Extended Mode Register should be issued to enable DLL, followed by another series of NOP/Deselect commands for at least tMRD. After this time, the Load Mode Register command should be issued to reset the DLL, again followed by a series of NOP or Deselect commands for at least tMRD. (Note: whenever the DLL is reset, 200 clock cycles must occur prior to any Read command.) The Pre-charge command is then issued, with NOP/ Deselect commands for at least tRP. Next, two Auto-Refresh commands are issued, each followed by NOP/ Deselect commands for at least tRFC. At this point, the JEDEC specification recommends that a DDR SDRAM receive another Load Mode Register command to clear the DLL, with NOP/Deselect commands for at least tMRD. The device is now ready to receive a valid command for normal operation.



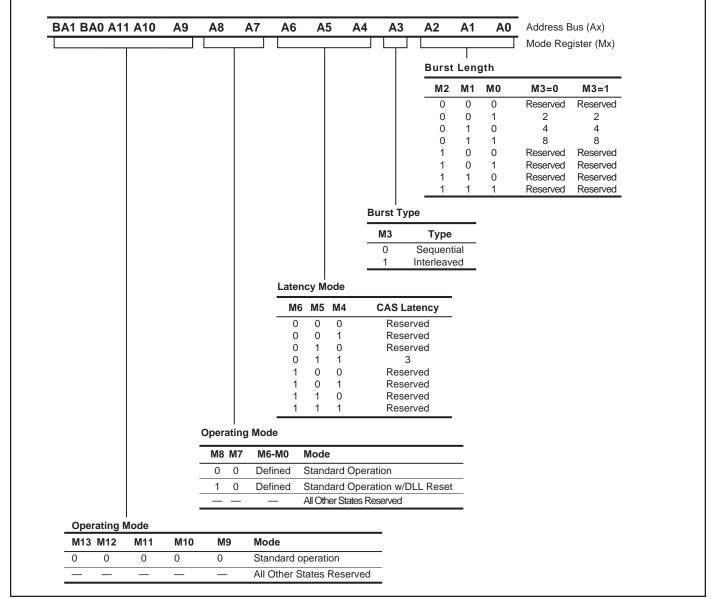
## POWER-UP SEQUENCE AFTER CKE GOES HIGH

## MODE REGISTER DEFINITION

The mode register allows configuration of the operating mode of the DDR SDRAM. This register is loaded as a step in the normal initialization of the device. The Load Mode Register command samples the values on inputs A0-A11, BA0 (Low) and BA1 (Low) and stores them as register values M0-M13. The values in the register determine the burst length, burst type, CAS latency timing, and DLL Reset/Clear. It should be noted that some bit values are reserved and should not be loaded into the register. The data in the mode register is retained until it is re-loaded or the DDR SDRAM loses its power (except for bit M8, which is cleared automatically). The register can be loaded only if all banks are idle. After the Load Mode Register command, a minimum time of tMRD must pass before the subsequent command is issued.

## CAS LATENCY

After a Read command is issued to the device, a latency of several clock cycles is necessary prior to the validity of data on the data bus. Also known as CAS Latency (CL), the value must be configured as 3, via the bits M4-M6 loaded into the register. If CL values are not defined, the device may not function properly.



## MODE REGISTER DEFINITION

## **BURST LENGTH**

The highest access throughput of this device can be achieved by using a burst of either Read or Write accesses. The number of accesses in each burst would be pre-configured to be 2, 4, or 8, as shown in Mode Register Definition (bits M0-M2). When a Read or Write command is given to the device, the address bits A0-A8 (x16) select the block of columns and the starting column for the subsequent burst. The accesses in this burst can only reference the selected block, and may wrap-around if a boundary is reached. The Burst Definition table indicates the relationship between the least significant address bits and the starting column. The most significant address bits can select any unique block of columns in the currently activated row.

## **BURST TYPE**

Bursts can be made in either of two types: sequential or interleaved. The burst type is programmed during a Load Mode Register command (bit M3). During a Read or Write burst, the order of accesses is determined by burst length, starting column, and burst type, as indicated in the Burst Definition table.

## **DLL RESET/CLEAR**

To cause a DLL reset, the bit M8 is set to 1 in the Load Mode Register command. When the DLL is reset, 200 clock cycles are required to occur prior to any Read operation. To clear the DLL for normal operation, the bit M8 is set to 0. This device does not require it, but JEDEC specifications require that any time that the DLL is reset, it later be cleared prior for normal operation.

## **BURST DEFINITION**

| Burst  | Sta            | rting Col | umn | Order of Acc    | cesses in a Burst |
|--------|----------------|-----------|-----|-----------------|-------------------|
| Length | Length Address |           | 5   | Sequential      | Interleaved       |
|        | A2             | A1        | A0  |                 |                   |
| 2      |                |           | 0   | 0-1             | 0-1               |
|        |                |           | 1   | 1-0             | 1-0               |
|        |                | 0         | 0   | 0-1-2-3         | 0-1-2-3           |
| 4      |                | 0         | 1   | 1-2-3-0         | 1-0-3-2           |
|        |                | 1         | 0   | 2-3-0-1         | 2-3-0-1           |
|        |                | 1         | 1   | 3-0-1-2         | 3-2-1-0           |
|        | 0              | 0         | 0   | 0-1-2-3-4-5-6-7 | 0-1-2-3-4-5-6-7   |
|        | 0              | 0         | 1   | 1-2-3-4-5-6-7-0 | 1-0-3-2-5-4-7-6   |
|        | 0              | 1         | 0   | 2-3-4-5-6-7-0-1 | 2-3-0-1-6-7-4-5   |
| 8      | 0              | 1         | 1   | 3-4-5-6-7-0-1-2 | 3-2-1-0-7-6-5-4   |
|        | 1              | 0         | 0   | 4-5-6-7-0-1-2-3 | 4-5-6-7-0-1-2-3   |
|        | 1              | 0         | 1   | 5-6-7-0-1-2-3-4 | 5-4-7-6-1-0-3-2   |
|        | 1              | 1         | 0   | 6-7-0-1-2-3-4-5 | 6-7-4-5-2-3-0-1   |
|        | 1              | 1         | 1   | 7-0-1-2-3-4-5-6 | 7-6-5-4-3-2-1-0   |

## **EXTENDED MODE REGISTER DEFINITION**

The Extended Mode Register is a second register to enable additional functions of the DDR SDRAM. This register is loaded as a step in the normal initialization of the device. The Load Extended Mode Register command samples the values on inputs A0-A11, BA0 (High) and BA1 (Low) and stores them as register values E0-E13. The additional functions are DLL enable/disable and output drive strength. Similarly to the Load Mode Register, the Load Extended Mode Register has reserved bit values, a bank idle prerequisite, and a tMRD time requirement. The data in the mode register is retained until it is reloaded or the device loses its power.

### **DLL Enable/Disable**

When the Load Extended Mode Register command is issued, DLL should be enabled (E0 = 0). Normal operation of the device requires this, but DLL can be disabled for debugging or evaluation, if necessary.

#### **Output Drive Strength**

Normal drive strength for the outputs is specified as SSTL 2. However, there is an option for reduced drive strength included.

| -     | RA1 | BA0 | Δ11 | Δ10 | ۵۹ | A8        | A7     | A6      | A5    | A4     | A3    | A2       | A1 | A0       | Address Bus (Ax)<br>Mode Register (Ex |
|-------|-----|-----|-----|-----|----|-----------|--------|---------|-------|--------|-------|----------|----|----------|---------------------------------------|
| Opera |     |     |     |     |    |           |        |         |       |        |       |          |    | DLL      |                                       |
| E13   | E12 |     |     |     |    | E8        | E7     | Mode    |       |        |       |          |    | E0       | Status                                |
| 0     | 1   | 0   | C   | )   | 0  | 0         | 0      | Standa  |       |        |       | <u> </u> |    | 0        | Enable                                |
|       | _   |     |     |     | _  | _         |        | All Oth | ner S | States | Reser | ved      |    | 1        | Disable                               |
|       |     |     |     |     |    | Driv      | ve Str | ength   |       |        |       |          |    |          |                                       |
|       |     |     |     |     |    | <b>E6</b> | E      | 5 E4    | Ļ     | E3     | E2    | E1       |    | Туре     |                                       |
|       |     |     |     |     |    | 0         | 0      | 0       |       | 0      | 0     | 0        |    | Full Str | ength                                 |
|       |     |     |     |     |    | 0         | 0      | 0       |       | 0      | 0     | 1        |    | Weak     |                                       |
|       |     |     |     |     |    | _         | _      |         |       |        | _     | _        |    | All Othe | r States Reserved                     |
|       |     |     |     |     |    |           |        |         |       |        |       |          |    |          |                                       |

## **EXTENDED MODE REGISTER DEFINITION**

## COMMANDS

All commands described in this section should be issued only when the initialization sequence is obeyed.

### **Deselect (DESL)**

This feature blocks unwanted commands from being executed. Chip select  $(\overline{CS})$  must be taken High to cause Deselect. Operations that are underway are not affected.

### No Operation (NOP)

NOP is a command that prevents new commands from being executed.  $\overline{CS}$  must be Low, while  $\overline{RAS}$ ,  $\overline{CAS}$ , and  $\overline{WE}$  must be High to issue NOP. NOP or Deselect commands must be issued during wait states to allow operations that are underway to continue uninterrupted.

### Load Mode Register (MRS)

The Base Mode Register is loaded during a step of initialization to configure the DDR SDRAM. Load Mode Register is issued when BA0 and BA1 are Low, and A0-A11 are selected according to the Mode Register Definition.

#### Load Extended Mode Register (EMRS)

The Extended Mode Register is loaded during a step of initialization to enable the DLL of the device. Load Extended Mode Register is issued when BA0 is High, BA1 is Low, and A0-A11 are selected according to the Extended Mode Register Definition.

## Read (READ/READA)

The Read command is used to begin a burst read access. When the command is given to the device, the BA0 and BA1 inputs select the bank, and address bits A0-A8 (x16) select the block of columns and the starting column for the subsequent burst. The crossing of the CLK and  $\overline{CLK}$  signals will cause the output values on the I/O pins to be valid. The Auto Precharge function is one option in the Read command. If the Auto Pre-charged following the Read burst. If the function is not enabled, the selected row will remain open for further accesses at the end of the Read burst.

## Write (WRIT/WRITA)

The Write command is used to begin a burst write access. When the command is given to the device, the BA0 and BA1 inputs select the bank, and address bits A0-A8 (x16) select the block of columns and the starting column for the subsequent burst. The rising edge on the Data Strobe input(s) will cause the input values on the Data Mask pin(s) and I/O pins to be sampled for the write operation. The Auto Pre-charge function is one option in the Write command. If the Auto Pre-charged following the Write burst. If the function is not enabled, the selected row will remain open for further accesses at the end of the Write burst.

### Pre-charge (PRE/PALL)

A Pre-charge command will de-activate an open row in a bank. The input A10 (x16) is sampled at this time to determine whether Pre-charge is applied to a single bank or all banks. After tRP, the bank has been precharged. It is de-activated, and goes into the idle state and must be activated before any Read or Write command can be issued to it. A Pre-charge command is treated as a NOP if either (a) the specified bank is already undergoing Pre-charge, or (b) the specified bank has no open row.

#### **Auto Pre-charge**

Auto Pre-charge is a feature that can be enabled as an option in a Read or Write command. If the input value on A10 (x16) is High during a Read or Write command, an automatic Pre-charge will occur just after the memory burst is completed. If the input value on A10 (x16) is Low, no Pre-charge will occur. With Auto Pre-charge, a minimum time of tRP must pass before the next command is issued to the same bank.

## Active (ACT)

The Active command opens a row in preparation for a Read or Write burst. The row stays open for accesses until the bank receives a Pre-charge command. Other rows in the bank cannot be opened until the bank is de-activated with a Pre-charge command and another Active command is issued.

#### **Burst Terminate (BST)**

The Burst Terminate command truncates the burst of the most recently issued Read command (with Auto Pre-charge disabled). The open row being accessed in the Read burst remains open.

### Auto Refresh (REF)

The DDR SDRAM is issued the Auto Refresh command during normal operation to maintain data in the memory array. All the banks must be idle for the command to be executed. The device has 4096 refresh cycles every 64ms.

#### Self Refresh (SELF)

To issue the Self Refresh command, CKE must be Low. When the DDR SDRAM is in Self Refresh mode, it retains the data contents without external clocking, and ignores other input signals. The DLL is disabled upon entering the Self Refresh mode, and is enabled again upon leaving the mode. To exit Self Refresh, all inputs must be stable prior to CKE going High. Next, a NOP command command must be issued on each clock cycle for at least tSNR to ensure that internal refresh operations are completed. To prepare for a memory access, the DDR SDRAM must receive a DLL reset followed by a NOP command for 200 clock cycles.

## **DEVICE OPERATION**

#### **Bank and Row Activation**

An Active command must be issued to the DDR SDRAM to open a bank and row prior to an access. The row will be available for a Read or Write command once a time tRCD has occurred. The Active command is depicted in the figure. As CLK goes High, CS and RAS are Low, while CKE, WE, and CAS are High. Upon issuing the Active command, the values on the address inputs specify the row, and BA0 and BA1 specify the bank. When an Active command is issued for a bank and row, another row in that same bank may be activated after a time tRC. When an Active command is issued for a bank and row, a row in a different bank may be activated after a time tRRD. (Note: to ensure that time requirement tRCD, tRC, or tRRD is met. NOP commands should be issued for a whole number of clock cycles that is greater than the time requirement (ie. tRCD) divided by the clock period.)

#### **Read Operation**

A Read command starts a burst from an activated row. The Read command is depicted in the figure. As CLK goes High,  $\overline{CS}$  and  $\overline{CAS}$  are Low, while  $\overline{RAS}$ , CKE, and  $\overline{WE}$  are High. The values on the inputs BA0 and BA1 specify the bank to access, and the address inputs specify the starting column in the open row. If Auto Pre-charge is enabled in the Read command, the open row will be pre-charged after completion of the Read burst. Unless stated otherwise, all timing diagrams for Read operations have disabled Auto Pre-charge.

The Read command causes data to be retrieved and placed in the pipeline. The subsequent command can be NOP, Read, or Terminate Burst. The data from the starting column specified in the Read command appears on I/O pins following a CAS latency of after the Read command. On each CLK and CLK crossing, the data from the next column in the burst sequence is output from the pipeline until the burst is completed (see Read Burst, Non-consecutive Read Burst, and Consecutive Read Burst). There are two cases in which a full Read burst length is not completed. The first is when the data retrieved from a subsequent Read burst interrupts the previous burst (see Random Read Accesses). The second is when a subsequent Burst Terminate command truncates the burst (see Terminating a Read Burst and Read to Write). The Burst Terminate and Read commands obey the same CAS latency timing such that they should be issued x cycles after a previous Read command, where x is the number of pairs of columns to output. By following a desired command sequence, continuous data can be output with either whole Read bursts or truncated Read bursts. Whenever a Read burst finishes and no other commands have been initiated, the I/O returns to High-Z.

If Auto Pre-charge is not enabled in the Read burst, the Pre-charge command can be issued separately following the Read command. The Pre-charge command should be received by the device x cycles after the Read command, where x is the desired number of pairs of columns to output during the Read burst. After the Pre-charge command, it is necessary to wait until both tRAS and tRP have been met before issuing a new command to the same bank.

Data Strobe output is driven synchronously with the output data on the I/O pins. The Low portion of the Data Strobe just prior to the first output data is the Read Pre-amble; and the Low portion coinciding with the last output data is the Read Post-amble. Before any Write command can be executed, any previous Read burst must have been completed normally or truncated by a Burst Terminate command. In the diagram Read to Write, a Burst Terminate command is issued to truncate a Read Burst early, and begin a Write operation. After the Write command, a time tDQSS is required prior to latching the data on the I/O.

## Write Operation

A Write command starts a burst from an activated row. The Write command is depicted in the figure. As CLK goes High,  $\overline{CS}$ ,  $\overline{WE}$ , and  $\overline{CAS}$  are Low, while CKE and  $\overline{RAS}$  are High. The values on the inputs BA0 and BA1 specify the bank to access, and the address inputs specify the starting column in the open row. If Auto Pre-charge is enabled in the Write command, the open row will be pre-charged after completion of the Write burst and time tWR. Unless stated otherwise, all timing diagrams for Write operations have disabled Auto Pre-charge.

The Write command in conjunction with Data Strobe inputs causes data to be latched and placed in the pipeline. The Low portion of the Data Strobe between the Write command and the first rising edge of the strobe is the Write Pre-amble; and the Low portion following the last input data is the Write Post-amble. A minimum time of tDQSS after the Write, the next command can be NOP or Write. The data that is to be written to the starting column specified in the Write command will be latched upon the first rising edge of Data Strobe input(s) LDQS, UDQS (x16) after that Write command. On each Data Strobe transition from Low-to-High or High-to-Low, the input values on the I/O are sampled, and enter pipeline to be written in the predetermined burst sequence (see Write Burst, Consecutive Write to Write, and Non-consecutive Write to Write). A new Write command can be issued x cycles after a previous Write command, where x is the number of pairs of columns to input. By following a desired command sequence, continuous data can be input with either whole Write bursts or truncated Write bursts. Whenever a Write burst finishes and no other commands have been initiated, the I/O returns to High-Z.

A Write burst may be followed by Read command, with or without truncating the Write burst. To avoid truncating the input data, the timing parameter tWTR should be obeyed before issuing the Read command (see Write to Read, Non-truncated). The period tWTR begins on the first positive clock edge after the last data input has been latched. The Write burst can be truncated deliberately by using the Data Mask feature and a Read command with an earlier timing (see Write to Read, Truncated).

If Auto Pre-charge is not enabled in the Write burst, the Pre-charge command can be issued separately some time following the Write command. The procedure to execute it is similar to the procedure to transition from a Write burst to a Read burst. To avoid truncating the input data, the timing parameter tWR should be obeyed before issuing the Pre-charge command (see Write to Pre-charge, Non-truncated). The period tWR begins on the first positive clock edge after the last data input has been latched. The Write burst can be truncated deliberately by using the Data Mask feature and a Pre-charge command with an earlier timing (see Write to Pre-charge, Truncated). After the Precharge command, it is necessary to wait until tRP has been met before issuing a new command to the same bank.

#### **Power Down Operation**

When the DDR SDRAM enters Power Down mode, power consumption is greatly reduced. To enter the mode, several conditions must be met. There must be neither a Read operation, nor a Write operation underway in the device at CLK positive edge n - 1, with CKE stable High. Prior to CLK positive edge n, CKE should go Low. A Power Down mode is entered if the appropriate command is issued as CLK n goes High. (If the command at CLK n is Auto Refresh, the SDRAM enters Self Refresh mode.) If the command at CLK n is NOP or Deselect, the device will enter Precharge Power Down mode or Active Power Down mode. While in a Power Down mode, CKE must be stable Low, and CLK and CLK signals maintained, while other inputs are ignored. Pre-charge Power Down mode conserves additional power by freezing the DLL. To exit the Power Down mode, normal voltages and clock frequency are applied. Prior to CLK positive edge n, CKE should go High. A NOP or Deselect command at CLK n, allows a valid command to be issued at CLK positive edge n + 1. (If exiting Self Refresh mode, the DLL is automatically enabled, and the device must be prepared according to the section describing Self Refresh.)

#### **Pre-charge Operation**

When this command is issued, either a particular bank, or all four banks will be de-activated after a time period of tRP. The bank(s) will be available for a row access until that time has occurred. The Pre-charge command is depicted in the figure. As CLK goes High,  $\overline{CS}$ ,  $\overline{RAS}$ , and  $\overline{WE}$  are Low, while CKE and  $\overline{CAS}$ are High. The values on the address inputs are Don't Care, except for the input A10 (x16), which determines whether a single bank is selected for Pre-charge, or all four banks. If A10 is Low, the inputs BA0 and BA1 select the single bank; however, if A10 is High, BA0 and BA1 are Don't Care. Once any bank has been precharged, it becomes idle. Before any row can have a Read or Write access, it must be activated.

#### COMMAND TRUTH TABLE

DDR SDRAM recognize the following commands specified by the  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$  and address pins. All other combinations than those in the table below are illegal.

|                                    |        | CKE |   |    |     |     |    |     |     |    |         |
|------------------------------------|--------|-----|---|----|-----|-----|----|-----|-----|----|---------|
| Command                            | Symbol | n–1 | n | CS | RAS | CAS | WE | BA1 | BA0 | AP | Address |
| Ignore command                     | DESL   | Н   | Н | Н  | х   | х   | х  | х   | х   | х  | х       |
| Nooperation                        | NOP    | Н   | Н | L  | Н   | Н   | Н  | х   | х   | х  | х       |
| Burst stop in read command         | BST    | Н   | Н | L  | Н   | Н   | L  | х   | х   | х  | х       |
| Column address and read command    | READ   | Н   | Н | L  | Н   | L   | Н  | V   | V   | L  | V       |
| Read with auto-precharge           | READA  | Н   | Н | L  | Н   | L   | Н  | V   | V   | Н  | V       |
| Column address and write command   | WRIT   | Н   | Н | L  | Н   | L   | L  | V   | V   | L  | V       |
| Write with auto-precharge          | WRITA  | Н   | Н | L  | Н   | L   | L  | V   | V   | Н  | V       |
| Row address strobe and bank active | ACT    | Н   | Н | L  | L   | Н   | Н  | V   | V   | V  | V       |
| Precharge select bank              | PRE    | Н   | Н | L  | L   | Н   | L  | V   | V   | L  | Х       |
| Precharge all bank                 | PALL   | Н   | Н | L  | L   | Н   | L  | х   | х   | Н  | Х       |
| Refresh                            | REF    | Н   | Н | L  | L   | L   | Н  | х   | х   | х  | х       |
|                                    | SELF   | Н   | L | L  | L   | L   | Н  | х   | х   | х  | х       |
| Mode register set                  | MRS    | Н   | Н | L  | L   | L   | L  | L   | L   | L  | V       |
|                                    | EMRS   | Н   | Н | L  | L   | L   | L  | L   | Н   | L  | V       |

**Remark:** H: VIH. L: VIL. **x**: VIH or VIL V: Valid address input **Note:** The CKE level must be kept for 1 CK cycle at least.

#### **CKE TRUTH TABLE**

|               |                            | CKE |   |           |     |     |    |         |       |
|---------------|----------------------------|-----|---|-----------|-----|-----|----|---------|-------|
| Current state | Command                    | n 1 | n | <u>CS</u> | RAS | CAS | WE | Address | Notes |
| Idle          | Auto-refresh command (REF) | Н   | Н | L         | L   | L   | Н  | х       | 2     |
| Idle          | Self-refresh entry (SELF)  | Н   | L | L         | L   | L   | Н  | х       | 2     |
| Idle          | Power down entry (PDEN)    | Н   | L | L         | Н   | Н   | Н  | х       |       |
|               |                            | Н   | L | Н         | х   | х   | х  | х       |       |
| Self refresh  | Self refresh exit (SELFX)  | L   | Н | L         | Н   | Н   | Н  | х       |       |
|               |                            | L   | Н | Н         | х   | х   | х  | х       |       |
| Powerdown     | Power down exit (PDEX)     | L   | Н | L         | Н   | Н   | Н  | х       |       |
|               |                            | L   | Н | Н         | х   | х   | Х  | х       |       |

Remark: H: VIH. L: VIL. x: VIH or VIL.

#### Notes:

1. All the banks must be in IDLE before executing this command.

2. The CKE level must be kept for 1 CK cycle at least.

#### **Function Truth Table**

The following tables show the operations that are performed when each command is issued in each state of the DDR SDRAM.

| Current state                           | /CS | /RAS | /CAS | /WE | Address     | Command    | Operation                               | Next state                          |
|---|-----|------|------|-----|-------------|------------|---|-------------------------------------|
| Precharging*1                           | Н   | ×    | ×    | ×   | ×           | DESL       | NOP                                     | ldle                                |
|   | L   | Н    | Н    | Н   | ×           | NOP        | NOP                                     | ldle                                |
|   | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL*11                              | _                                   |
|   | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL*11                              | _                                   |
|   | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | NOP                                     | Idle                                |
|   | L   | L    | L    | ×   | ×           |            | ILLEGAL                                 | _                                   |
| ldle*2                                  | Н   | ×    | ×    | ×   | ×           | DESL       | NOP                                     | ldle                                |
|   | L   | Н    | Н    | Н   | ×           | NOP        | NOP                                     | ldle                                |
|   | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL*11                              | _                                   |
|   | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | L    | Н    | Н   | BA, RA      | ACT        | Activating                              | Active                              |
|   | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | NOP                                     | Idle                                |
|   | L   | L    | L    | Н   | ×           | REF, SELF  | Refresh/<br>Self refresh* <sup>12</sup> | ldle/<br>Self refresh               |
|   | L   | L    | L    | L   | MODE        | MRS        | Mode register set*12                    | ldle                                |
| Refresh<br>(auto-refresh)* <sup>3</sup> | Н   | ×    | ×    | ×   | ×           | DESL       | NOP                                     | ldle                                |
|   | L   | Н    | Н    | Н   | ×           | NOP        | NOP                                     | ldle                                |
|   | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL                                 | _                                   |
|   | L   | Н    | L    | ×   | ×           |            | ILLEGAL                                 | _                                   |
|   | L   | L    | ×    | ×   | ×           |            | ILLEGAL                                 | _                                   |
| Activating*4                            | Н   | ×    | ×    | ×   | ×           | DESL       | NOP                                     | Active                              |
|   | L   | Н    | Н    | Н   | ×           | NOP        | NOP                                     | Active                              |
|   | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | ILLEGAL*11                              | _                                   |
|   | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | ILLEGAL*11                              | _                                   |
|   | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | ILLEGAL* <sup>11</sup>                  | _                                   |
|   | L   | L    | L    | ×   | ×           |            | ILLEGAL                                 | _                                   |
| Active*5                                | Н   | ×    | ×    | ×   | ×           | DESL       | NOP                                     | Active                              |
|   | L   | Н    | Н    | Н   | ×           | NOP        | NOP                                     | Active                              |
|   | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL                                 | Active                              |
|   | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | Starting read operation                 | Read/READA                          |
|   | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | Starting write operation                | Write<br>recovering/<br>precharging |
|   | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL* <sup>11</sup>                  |                                     |
|   | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | Pre-charge                              | Idle                                |
|   | L   | L    | L    | ×   | ×           |            | ILLEGAL                                 | _                                   |

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| Current state                              | /CS | /RAS | /CAS | /WE | Address     | Command    | Operation   | Next state          |
|--|-----|------|------|-----|-------------|------------|---|---------------------|
| Read* <sup>6</sup>                         | Н   | ×    | ×    | ×   | ×           | DESL       | NOP   | Active              |
|  | L   | Н    | Н    | Н   | ×           | NOP        | NOP   | Active              |
|  | L   | Н    | Н    | L   | ×           | BST        | BST   | Active              |
|  | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | Interrupting burst read<br>operation to<br>start new read                 | Active              |
|  | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | ILLEGAL* <sup>13</sup>  | _                   |
|  | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL*11  | _                   |
|  | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | Interrupting burst<br>read operation to<br>start pre-charge               | Precharging         |
|  | L   | L    | L    | ×   | ×           |            | ILLEGAL   | _                   |
| Read with auto-pre-<br>harge* <sup>7</sup> | Η   | ×    | ×    | ×   | ×           | DESL       | NOP   | Precharging         |
|  | L   | Н    | Н    | Н   | ×           | NOP        | NOP   | Precharging         |
|  | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL   | _                   |
|  | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | ILLEGAL* <sup>14</sup>  | _                   |
|  | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | ILLEGAL*14  | _                   |
|  | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL*11, 14  | _                   |
|  | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | ILLEGAL*11, 14  | _                   |
|  | L   | L    | L    | ×   | ×           |            | ILLEGAL   |                     |
| Write* <sup>8</sup>                        | Н   | ×    | ×    | ×   | ×           | DESL       | NOP   | Write recovering    |
|  | L   | Η    | Н    | Н   | ×           | NOP        | NOP   | Write<br>recovering |
|  | L   | Н    | Н    | L   | ×           | BST        | ILLEGAL   | _                   |
|  | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | Interrupting burst write<br>operation to<br>start read operation.         | Read/ReadA          |
|  | L   | Η    | L    | L   | BA, CA, A10 | WRIT/WRITA | Interrupting burst write<br>operation to<br>start new write<br>operation. | Write/WriteA        |
|  | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL* <sup>11</sup>  | _                   |
|  | L   | L    | Н    | L   | BA, A10     | PRE, PALL  | Interrupting write<br>operation to start pre-<br>charge.                  | Idle                |
|  | L   | L    | L    | ×   | X           |            | ILLEGAL   | _                   |
| Vrite recovering*9                         | Н   | ×    | ×    | ×   | Х           | DESL       | NOP   | Active              |
|  | L   | Н    | Н    | Н   | X           | NOP        | NOP   | Active              |
|  | L   | Н    | Н    | L   | X           | BST        | ILLEGAL   | _                   |
|  | L   | Н    | L    | Н   | BA, CA, A10 | READ/READA | Starting read operation.  | Read/ReadA          |
|  | L   | Н    | L    | L   | BA, CA, A10 | WRIT/WRITA | Starting new write operation.   | Write/WriteA        |
|  | L   | L    | Н    | Н   | BA, RA      | ACT        | ILLEGAL* <sup>11</sup>  | _                   |
|  | L   | L    | Н    | L   | BA, A10     | PRE/PALL   | ILLEGAL* <sup>11</sup>  | _                   |
|  | L   | L    | L    | ×   | ×           |            | ILLEGAL   | _                   |

| Current state                                 | /CS | /RAS    | /CAS | /WE | Address     | Command     | Operation                  | Next state  |
|---|-----|---------|------|-----|-------------|-------------|----------------------------|-------------|
| Write with auto-<br>pre-charge* <sup>10</sup> | Н   | × × × × |      | ×   | DESL        | NOP         | Precharging                |             |
|   | L   | Н       | Н    | Н   | ×           | NOP         | NOP                        | Precharging |
|   | L   | Н       | Н    | L   | ×           | BST         | ILLEGAL                    | _           |
|   | L   | Н       | L    | Н   | BA, CA, A10 | READ/READA  | ILLEGAL* <sup>14</sup>     | _           |
|   | L   | Н       | L    | L   | BA, CA, A10 | WRIT/WRIT A | ILLEGAL* <sup>14</sup>     | _           |
|   | L   | L       | Н    | Н   | BA, RA      | ACT         | ILLEGAL* <sup>11, 14</sup> | _           |
|   | L   | L       | Н    | L   | BA, A10     | PRE, PALL   | ILLEGAL* <sup>11, 14</sup> | _           |
|   | L   | L       | L    | ×   | ×           |             | ILLEGAL                    | _           |

Remark: H: VIH. L: VIL. X: VIH or VIL

Notes: 1. The DDR SDRAM is in "Precharging" state for tRP after precharge command is issued.

- 2. The DDR SDRAM reaches "IDLE" state tRP after precharge command is issued.
- 3. The DDR SDRAM is in "Refresh" state for tRFC after auto-refresh command is issued.
- 4. The DDR SDRAM is in "Activating" state for tRCD after ACT command is issued.
- 5. The DDR SDRAM is in "Active" state after "Activating" is completed.
- The DDR SDRAM is in "READ" state until burst data have been output and DQ output circuits are turned off.
- The DDR SDRAM is in "READ with auto-precharge" from READA command until burst data has been output and DQ output circuits are turned off.
- 8. The DDR SDRAM is in "WRITE" state from WRIT command to the last burst data are input.
- 9. The DDR SDRAM is in "Write recovering" for tWR after the last data are input.
- 10. The DDR SDRAM is in "Write with auto-precharge" until tWR after the last data has been input.
- 11. This command may be issued for other banks, depending on the state of the banks.
- 12. All banks must be in "IDLE".
- 13. Before executing a write command to stop the preceding burst read operation, BST command must be issued.
- 14. The DDR SDRAM supports the concurrent auto-precharge feature, a read with auto-precharge enabled, or a write with auto-precharge enabled, may be followed by any column command to other banks, as long as that command does not interrupt the read or write data transfer, and all other related limitations apply. (E.g. Conflict between READ data and WRITE data must be avoided.)

The minimum delay from a read or write command with auto precharge enabled, to a command to a different bank, is summarized below.

| From command | To command (different bank, non-<br>interrupting command) | Minimum delay<br>(Concurrent AP supported) | Units |
|--------------|---|--|-------|
| Read w/AP    | Read or Read w/AP   | BL/2                                       | tCK   |
|              | Write or Write w/AP                                       | CL(rounded up)+ (BL/2)                     | tCK   |
|              | Precharge or Activate                                     | 1  | tCK   |
| Write w/AP   | Read or Read w/AP   | 1 + (BL/2) + tWTR                          | tCK   |
|              | Write or Write w/AP                                       | BL/2                                       | tCK   |
|              | Precharge or Activate                                     | 1  | tCK   |

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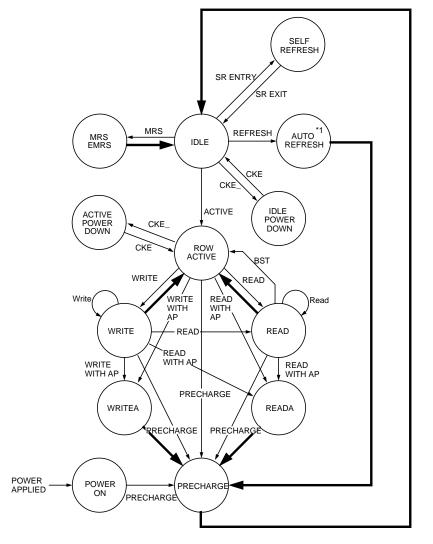
#### Command Truth Table for CKE

| Current State         | CKE   |   | _   |      |      |     |         |   |       |
|-----------------------|-------|---|-----|------|------|-----|---------|---|-------|
|                       | n – 1 | n | /CS | /RAS | /CAS | /WE | Address | Operation                                   | Notes |
| Self refresh          | Н     | × | ×   | ×    | ×    | ×   | ×       | INVALID, CK (n-1) would exit self refresh   |       |
|                       | L     | Н | Н   | ×    | ×    | ×   | ×       | Self refresh recovery                       |       |
|                       | L     | Н | L   | Н    | Н    | ×   | ×       | Self refresh recovery                       |       |
|                       | L     | Н | L   | Н    | L    | ×   | ×       | ILLEGAL                                     |       |
|                       | L     | Н | L   | L    | ×    | ×   | ×       | ILLEGAL                                     |       |
|                       | L     | L | ×   | ×    | ×    | ×   | ×       | Maintain self refresh                       |       |
| Self refresh recovery | Н     | Н | Н   | ×    | ×    | ×   | ×       | Idle after tRC                              |       |
|                       | Н     | Н | L   | Н    | Н    | ×   | ×       | Idle after tRC                              |       |
|                       | Н     | Н | L   | Н    | L    | ×   | ×       | ILLEGAL                                     |       |
|                       | Н     | Н | L   | L    | ×    | ×   | ×       | ILLEGAL                                     |       |
|                       | Н     | L | Н   | ×    | ×    | ×   | ×       | ILLEGAL                                     |       |
|                       | Н     | L | L   | Н    | Н    | ×   | ×       | ILLEGAL                                     |       |
|                       | Н     | L | L   | Н    | L    | ×   | ×       | ILLEGAL                                     |       |
|                       | Н     | L | L   | L    | ×    | ×   | ×       | ILLEGAL                                     |       |
| Power down            | Н     | × | ×   | ×    | ×    | ×   |         | INVALID, CK (n – 1) would exit power down   |       |
|                       | L     | Н | Н   | ×    | ×    | ×   | ×       | EXIT power down $\rightarrow$ Idle          |       |
|                       | L     | Н | L   | Н    | Н    | Н   | ×       |   |       |
|                       | L     | L | ×   | ×    | ×    | ×   | ×       | Maintain power down mode                    |       |
| All banks idle        | Н     | Н | Н   | ×    | ×    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | Н | L   | Н    | ×    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | Н | L   | L    | Н    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | Н | L   | L    | L    | Н   | ×       | CBR (auto) refresh                          |       |
|                       | Н     | Н | L   | L    | L    | L   | OPCODE  | Refer to operations in Function Truth Table |       |
|                       | Н     | L | Н   | ×    | ×    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | L | L   | Н    | ×    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | L | L   | L    | Н    | ×   |         | Refer to operations in Function Truth Table |       |
|                       | Н     | L | L   | L    | L    | Н   | ×       | Self refresh                                | 1     |
|                       | Н     | L | L   | L    | L    | L   | OPCODE  | Refer to operations in Function Truth Table |       |
|                       | L     | × | ×   | ×    | ×    | ×   | ×       | Power down                                  | 1     |
| Row active            | Н     | × | ×   | ×    | ×    | ×   | ×       | Refer to operations in Function Truth Table |       |
|                       | L     | × | ×   | ×    | ×    | ×   | ×       | Power down                                  | 1     |

Remark: H: VIH. L: VIL. X: VIH or VIL

Note: Self refresh can be entered only from the all banks idle state. Power down can be entered only from all banks idle or row active state.

#### Simplified State Diagram



Automatic transition after completion of command. Transition resulting from command input.

Note: 1. After the auto-refresh operation, precharge operation is performed automatically and enter the IDLE state.

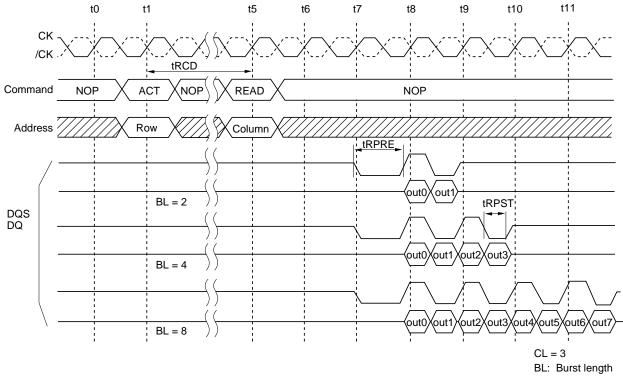
#### **Read/Write Operations**

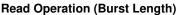
#### **Bank active**

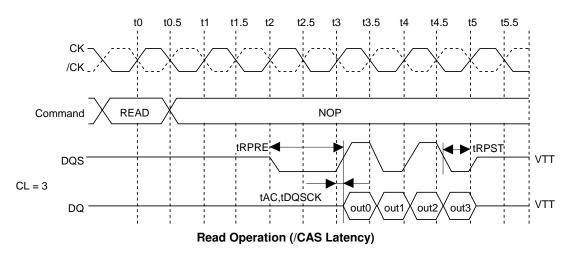
A read or a write operation begins with the bank active command [ACT]. The bank active command determines a bank address and a row address. For the bank and the row, a read or a write command can be issued tRCD after the ACT is issued.

#### **Read operation**

The burst length (BL), the /CAS latency (CL) and the burst type (BT) of the mode register are referred when a read command is issued. The burst length (BL) determines the length of a sequential output data by the read command that can be set to 2, 4, or 8. The starting address of the burst read is defined by the column address, the bank select address which are loaded via the A0 to A11 and BA0, BA1 pins in the cycle when the read command is issued. The data output timing are characterized by CL and tAC. The read burst start CL x tCK + tAC (ns) after the clock rising edge where the read command are latched. The DDR SDRAM output the data strobe through DQS simultaneously with data. tRPRE prior to the first rising edge of the data strobe, the DQS are driven Low from VTT level. This low period of DQS is referred as read preamble. The burst data are output coincidentally at both the rising and falling edge of the data strobe, the DQS pins become High-Z. This low period of DQS is referred as read preamble.

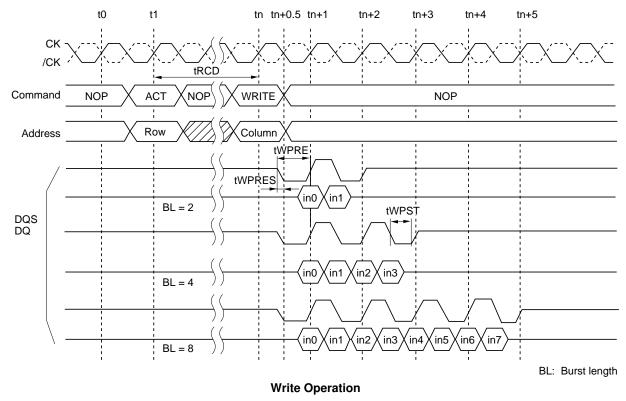






#### Write operation

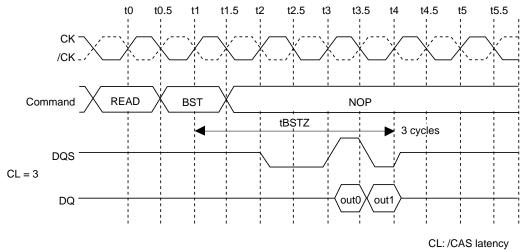
The burst length (BL) and the burst type (BT) of the mode register are referred when a write command is issued. The burst length (BL) determines the length of a sequential data input by the write command that can be set to 2, 4, or 8. The latency from write command to data input is fixed to 1. The starting address of the burst read is defined by the column address, the bank select address which are loaded via the A0 to A11, BA0 to BA1 pins in the cycle when the write command is issued. DQS should be input as the strobe for the input-data and DM as well during burst operation. tWPRE prior to the first rising edge of the DQS should be set to Low and tWPST after the last falling edge of the data strobe can be set to High-Z. The leading low period of DQS is referred as write preamble. The last low period of DQS is referred as write postamble.



#### **Burst Stop**

#### Burst stop command during burst read

The burst stop (BST) command is used to stop data output during a burst read. The BST command stops the burst read and sets the output buffer to High-Z. tBSTZ (= CL) cycles after a BST command issued, the DQ pins become High-Z. The BST command is not supported for the burst write operation. Note that bank address is not referred when this command is executed.



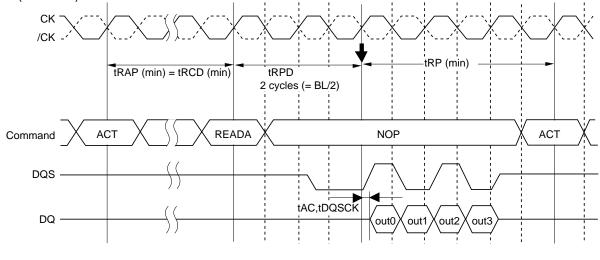
Burst Stop during a Read Operation



#### **Auto Precharge**

#### Read with auto-precharge

The precharge is automatically performed after completing a read operation. The precharge starts tRPD (BL/2) cycle after READA command input. tRAP specification for READA allows a read command with auto precharge to be issued to a bank that has been activated (opened) but has not yet satisfied the tRAS (min) specification. A column command to the other active bank can be issued the next cycle after the last data output. Read with auto-precharge command does not limit row commands execution for other bank. Refer to 'Function truth table and related note(Notes.\*14).

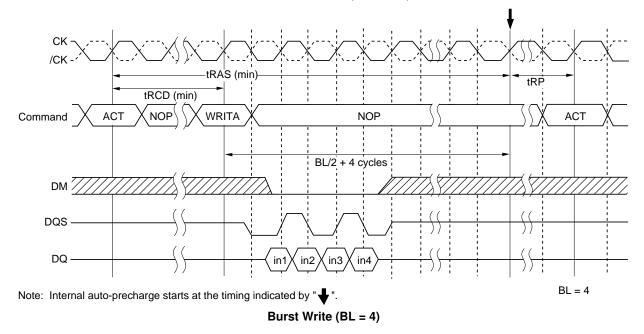


Note: Internal auto-precharge starts at the timing indicated by "

#### Read with auto-precharge

#### Write with auto-precharge

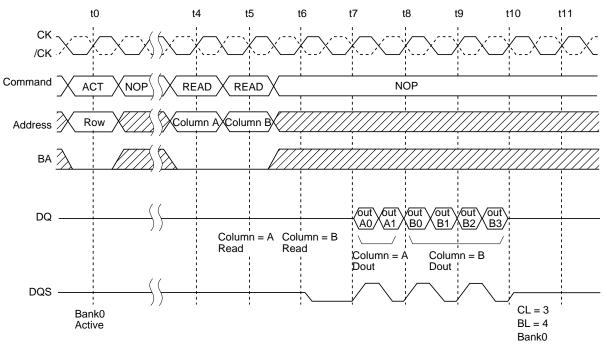
The precharge is automatically performed after completing a burst write operation. The precharge operation is started (BL/2 + 4) cycles after WRITA command issued. A column command to the other banks can be issued the next cycle after the internal precharge command issued. Write with auto-precharge command does not limit row commands execution for other bank. Refer to the 'Read with Auto-Precharge Enabled, Write with Auto-Precharge Enabled' section. Refer to 'Function truth table and related note(Notes.\*14)'.



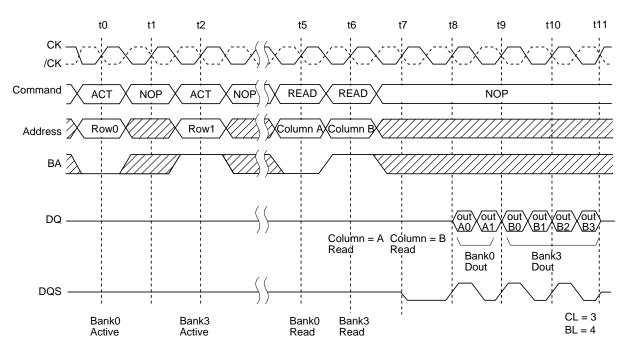
### **Command Intervals**

#### A Read command to the consecutive Read command Interval

|    | Destination r<br>consecutive | ow of the read command |        |   |
|----|------------------------------|------------------------|--------|---|
|    | Bank<br>address              | Row address            | State  | Operation   |
| 1. | Same                         | Same                   | ACTIVE | The consecutive read can be performed after an interval of no less than 1 cycle to interrupt the preceding read operation.  |
| 2. | Same                         | Different              | _      | Precharge the bank to interrupt the preceding read operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive read command can be issued. See 'A read command to the consecutive precharge interval' section. |
| 3. | Different                    | Any                    | ACTIVE | The consecutive read can be performed after an interval of no less than 1 cycle to interrupt the preceding read operation.  |
|    |                              |                        | IDLE   | Precharge the bank without interrupting the preceding read operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive read command can be issued.   |



READ to READ Command Interval (same ROW address in the same bank)

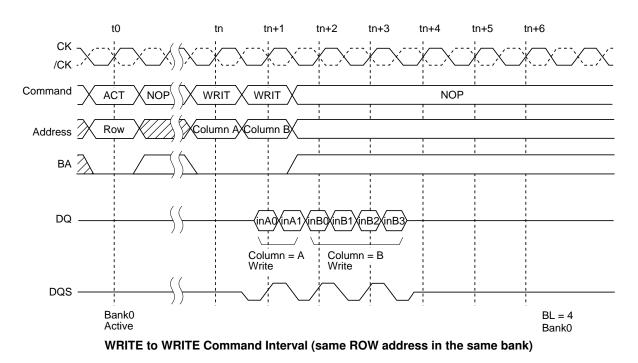


READ to READ Command Interval (different bank)

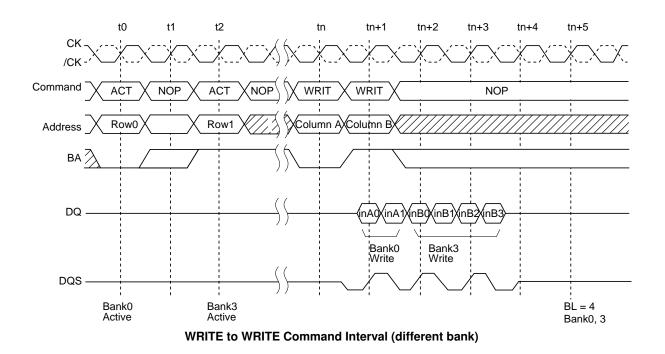
#### A Write command to the consecutive Write command Interval

Destination row of the consecutive write

|    | command         |             |        |  |
|----|-----------------|-------------|--------|--|
|    | Bank<br>address | Row address | State  | Operation  |
| 1. | Same            | Same        | ACTIVE | The consecutive write can be performed after an interval of no less than 1 cycle to interrupt the preceding write operation.   |
| 2. | Same            | Different   | _      | Precharge the bank to interrupt the preceding write operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive write command can be issued. See 'A write command to the consecutive precharge interval' section. |
| 3. | Different       | Any         | ACTIVE | The consecutive write can be performed after an interval of no less than 1 cycle to interrupt the preceding write operation.   |
|    |                 |             | IDLE   | Precharge the bank without interrupting the preceding write operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive write command can be issued.  |

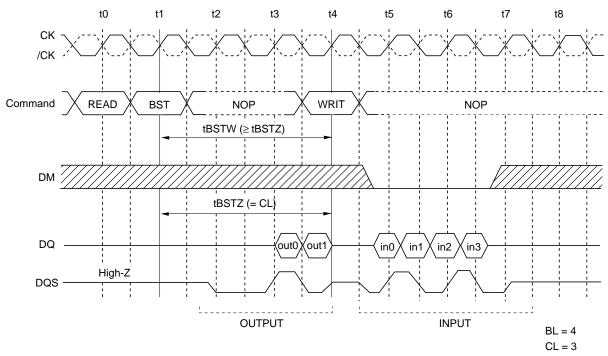






#### A Read command to the consecutive Write command interval with the BST command

|    | Destination command | row of the conse | ecutive write |  |
|----|---------------------|------------------|---------------|--|
|    | Bank<br>address     | Row address      | State         | Operation  |
| 1. | Same                | Same             | ACTIVE        | Issue the BST command. tBSTW (≥ tBSTZ) after the BST command, the consecutive write command can be issued.   |
| 2. | Same                | Different        | _             | Precharge the bank to interrupt the preceding read operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive write command can be issued. See 'A read command to the consecutive precharge interval' section. |
| 3. | Different           | Any              | ACTIVE        | Issue the BST command. tBSTW (≥ tBSTZ) after the BST command, the consecutive write command can be issued.   |
|    |                     |                  | IDLE          | Precharge the bank independently of the preceding read operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive write command can be issued.   |



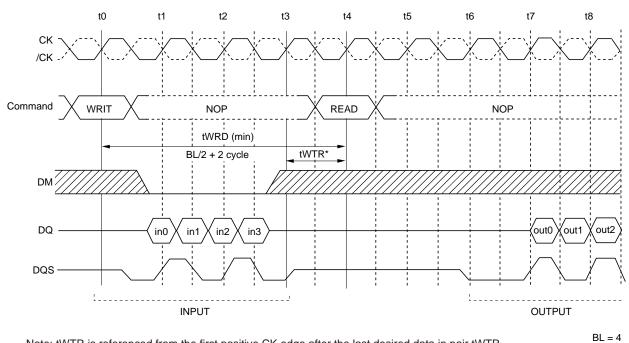
**READ to WRITE Command Interval** 



#### A Write command to the consecutive Read command interval: To complete the burst operation

Destination row of the consecutive read

|    | command         |             |        |  |
|----|-----------------|-------------|--------|--|
|    | Bank<br>address | Row address | State  | Operation  |
| 1. | Same            | Same        | ACTIVE | To complete the burst operation, the consecutive read command should be performed tWRD (= BL/ 2 + 2) after the write command.  |
| 2. | Same            | Different   | _      | Precharge the bank tWPD after the preceding write command. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive read command can be issued. See 'A read command to the consecutive precharge interval' section. |
| 3. | Different       | Any         | ACTIVE | To complete a burst operation, the consecutive read command should be performed tWRD (= BL/ 2 + 2) after the write command.  |
|    |                 |             | IDLE   | Precharge the bank independently of the preceding write operation. tRP after the precharge command, issue the ACT command. tRCD after the ACT command, the consecutive read command can be issued.   |



Note: tWTR is referenced from the first positive CK edge after the last desired data in pair tWTR. BL = 4 CL = 3

#### WRITE to READ Command Interval

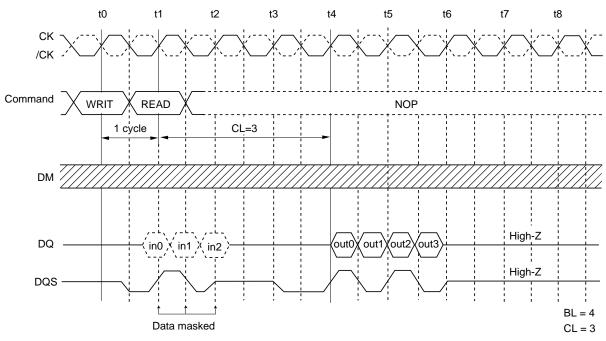
#### A Write command to the consecutive Read command interval: To interrupt the write operation

Destination row of the consecutive read

|    | command         |             |        |  |
|----|-----------------|-------------|--------|--|
| _  | Bank<br>address | Row address | State  | Operation  |
| 1. | Same            | Same        | ACTIVE | DM must be input 1 cycle prior to the read command input to prevent from being written invalid data. In case, the read command is input in the next cycle of the write command, DM is not necessary. |
| 2. | Same            | Different   | _      | * <sup>1</sup>   |
| 3. | Different       | Any         | ACTIVE | DM must be input 1 cycle prior to the read command input to prevent from being written invalid data. In case, the read command is input in the next cycle of the write command, DM is not necessary. |
|    |                 |             | IDLE   | * <sup>1</sup>   |

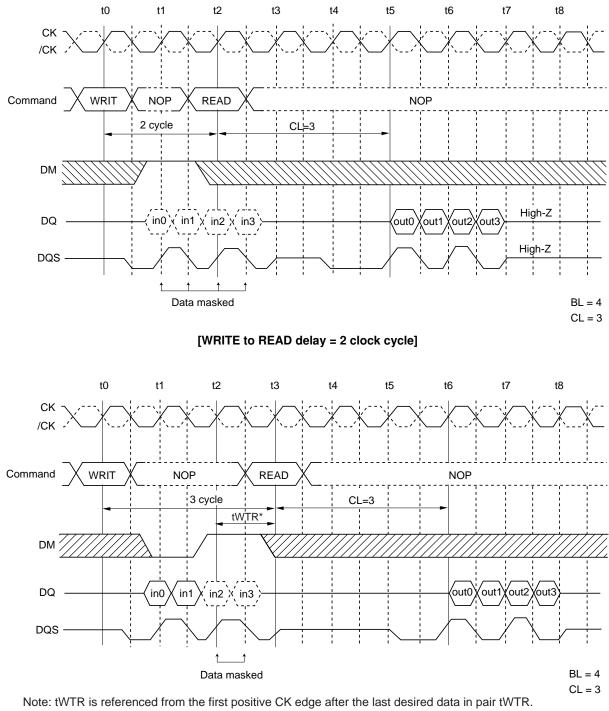
Note: 1. Precharge must be preceded to read command. Therefore read command can not interrupt the write operation in this case.

#### WRITE to READ Command Interval (Same bank, same ROW address)



[WRITE to READ delay = 1 clock cycle]

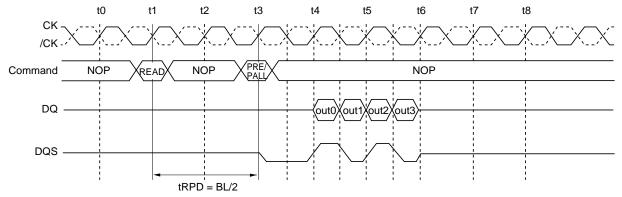




[WRITE to READ delay = 3 clock cycle]

#### A Read command to the consecutive Precharge command interval (same bank): To output all data

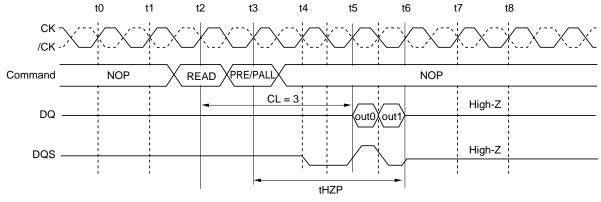
To complete a burst read operation and get a burst length of data, the consecutive precharge command must be issued tRPD (= BL/ 2 cycles) after the read command is issued.



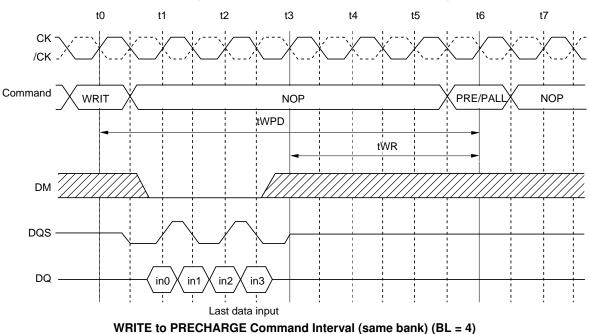
READ to PRECHARGE Command Interval (same bank): To output all data (CL = 3, BL = 4)

#### READ to PRECHARGE Command Interval (same bank): To stop output data

A burst data output can be interrupted with a precharge command. All DQ pins and DQS pins become High-Z tHZP (= CL) after the precharge command.



READ to PRECHARGE Command Interval (same bank): To stop output data (CL = 3, BL = 2, 4, 8)

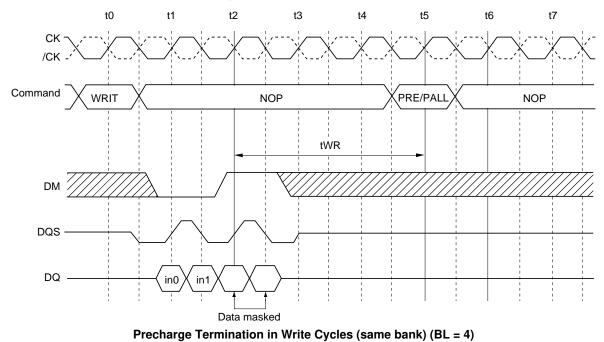


#### A Write command to the consecutive Precharge command interval (same bank)

The minimum interval tWPD is necessary between the write command and the precharge command.

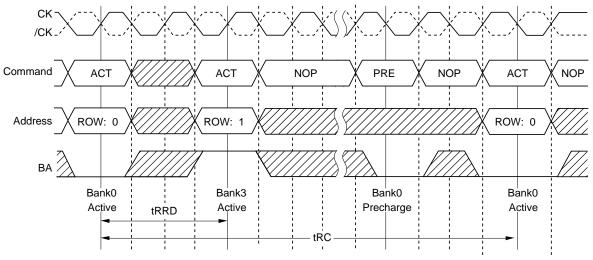
#### Precharge Termination in Write Cycles

During a burst write cycle without auto precharge, the burst write operation is terminated by a precharge command of the same bank. In order to write the last input data, tWR (min) must be satisfied. When the precharge command is issued, the invalid data must be masked by DM.



#### Bank active command interval

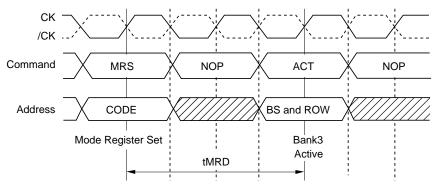
|    | Destination command | row of the cons | ecutive ACT |   |
|----|---------------------|-----------------|-------------|---|
|    | Bank<br>address     | Row address     | State       | Operation   |
| 1. | Same                | Any             | ACTIVE      | Two successive ACT commands can be issued at tRC interval. In between two<br>successive ACT operations, precharge command should be executed. |
| 2. | Different           | Any             | ACTIVE      | Precharge the bank. tRP after the precharge command, the consecutive ACT command can be issued.   |
|    |                     |                 | IDLE        | tRRD after an ACT command, the next ACT command can be issued.  |



**Bank Active to Bank Active** 

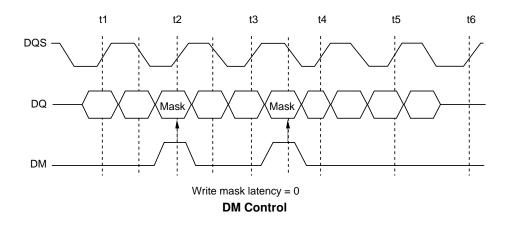
#### Mode register set to Bank-active command interval

The interval between setting the mode register and executing a bank-active command must be no less than tMRD.



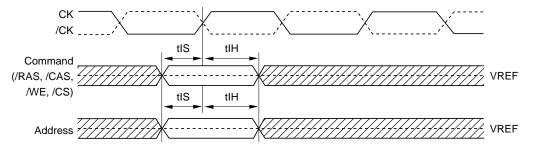
#### **DM Control**

DM can mask input data. In  $\times$ 16 products, UDM and LDM can mask the upper and lower byte of input data, respectively. By setting DM to Low, data can be written. When DM is set to High, the corresponding data is not written, and the previous data is held. The latency between DM input and enabling/disabling mask function is 0.

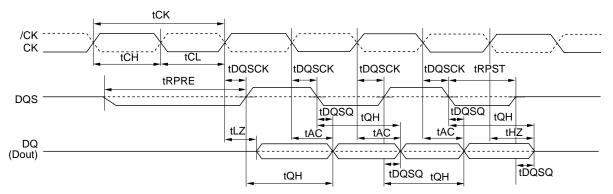


#### **Timing Waveforms**

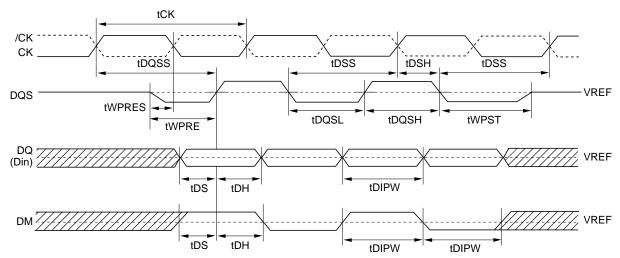
#### **Command and Addresses Input Timing Definition**



#### **Read Timing Definition**



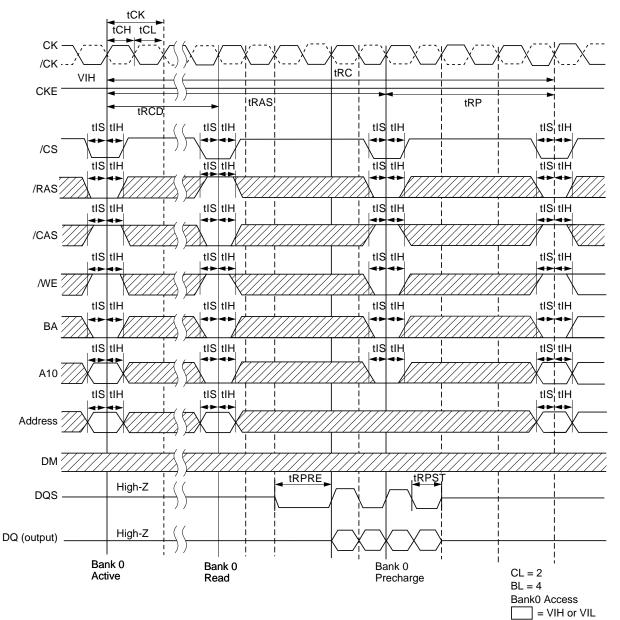
#### Write Timing Definition



## IS43R16800A

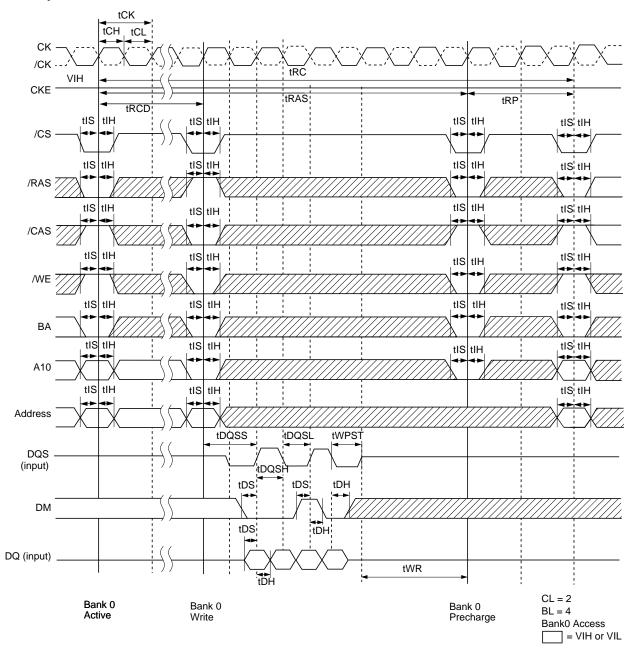


**Read Cycle** 

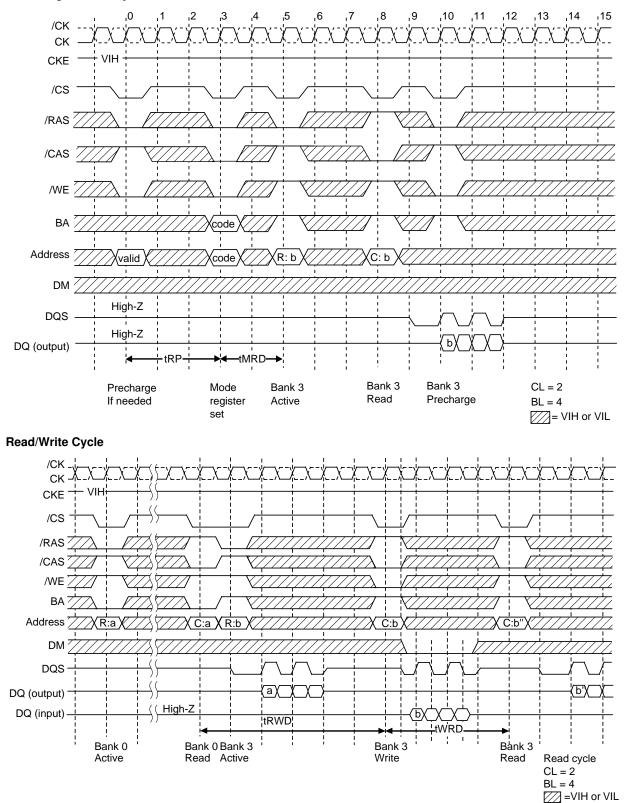


## IS43R16800A

Write Cycle

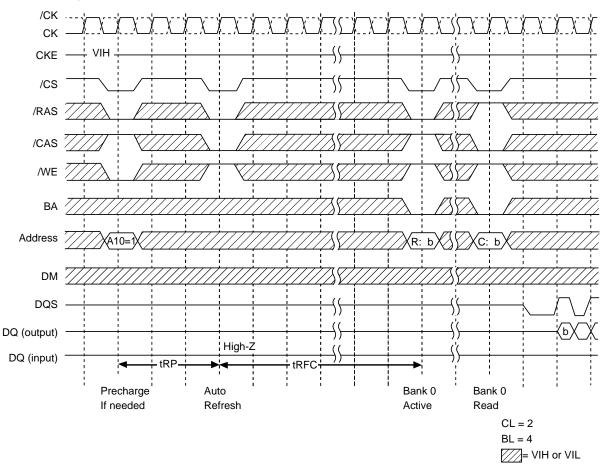


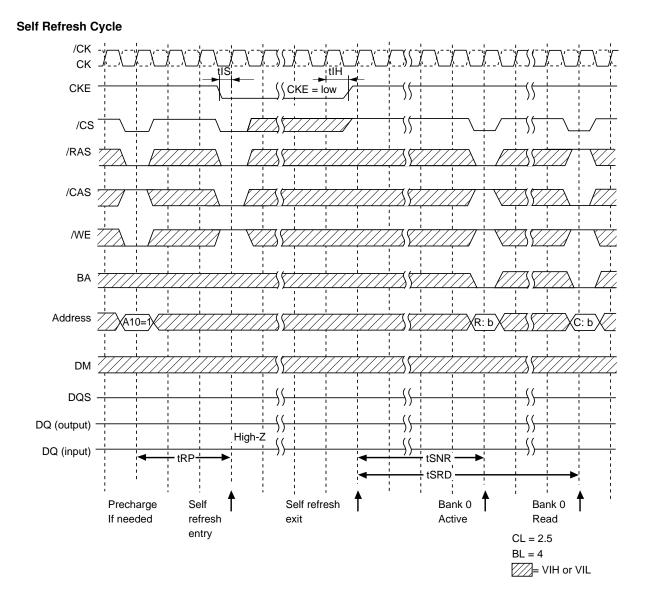




#### Mode Register Set Cycle

Auto Refresh Cycle





#### Integrated Silicon Solution, Inc. — 1-800-379-4774 Rev. 00A 07/11/05

## **ORDERING INFORMATION**

## Commercial Range: 0°C to +70°C

| Frequency | Speed (ns) | Order Part No.  | Package                   |  |
|-----------|------------|-----------------|---------------------------|--|
| 400 MHz   | 5          | IS43R16800A-5T  | 66-pin TSOP-II            |  |
| 400 MHz   | 5          | IS43R16800A-5TL | 66-pin TSOP-II, Lead-free |  |

## PACKAGING INFORMATION



## Plastic TSOP 66-pin Package Code: T (Type II)

